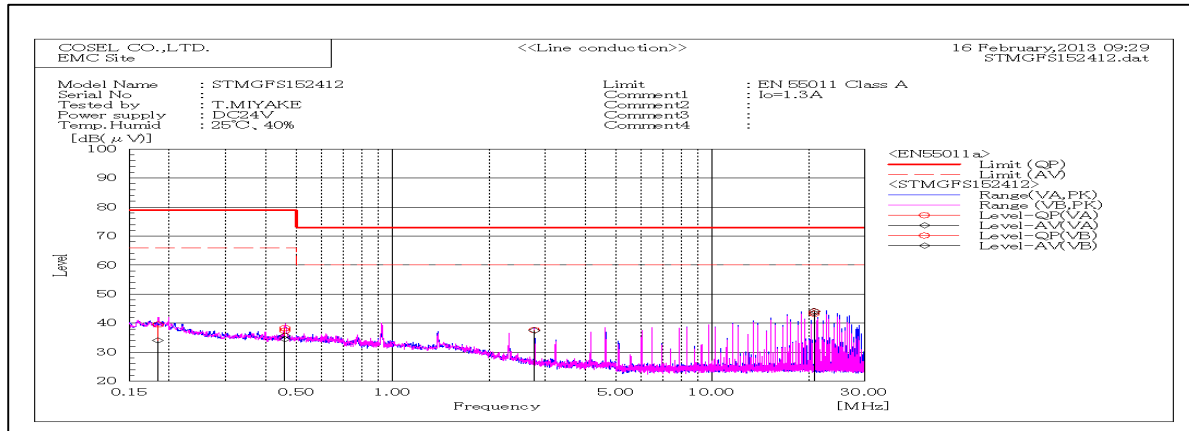
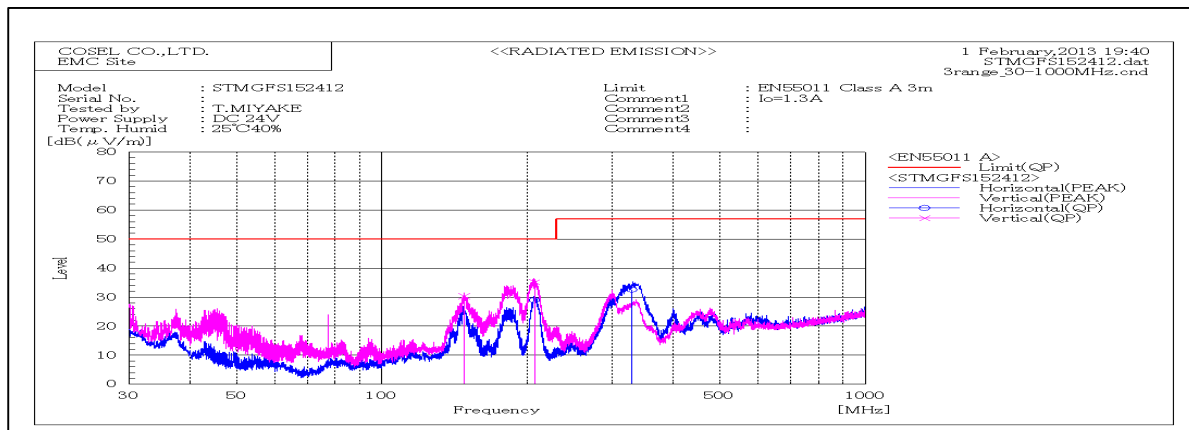


DATA SHEET		Date	18-Feb-13
Model	STMGFS152412	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake



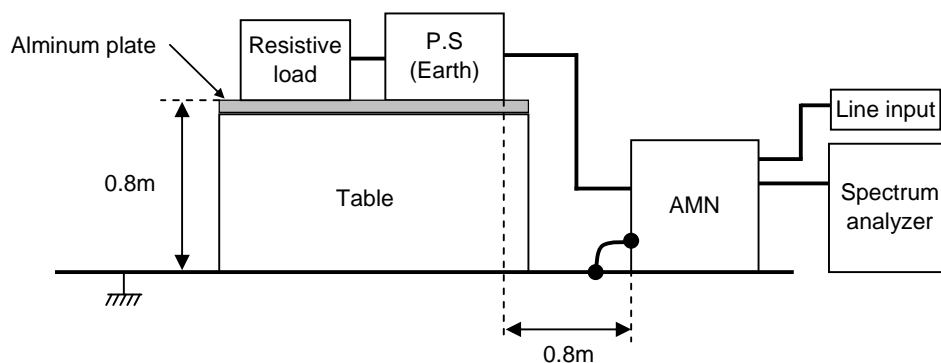
Frequency MHz	Harm	Line Phase	Reading dB(uV)		Factor dB	Level dB(uV)		Limit dB(uV)		Margin dB		Pass/ Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.18431		VB	19.3	13.8	20.2	39.5	34	79	66	39.5	32	Pass	
0.45949		VA	17.3	14.5	20.1	37.4	34.6	79	66	41.6	31.4	Pass	
0.46002		VB	18.2	15.6	20.1	38.3	35.7	79	66	40.7	30.3	Pass	
2.77044		VB	17.4	17.2	20.3	37.7	37.5	73	60	35.3	22.5	Pass	
20.78515		VB	22	22.3	21.2	43.2	43.5	73	60	29.8	16.5	Pass	
20.78465		VA	22.7	23	21.2	43.9	44.2	73	60	29.1	15.8	Pass	



Frequency MHz	Polarization	Stability	Reading dB(uV)		Space Loss dB	Level dB(mW)		Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV		QP	QP	QP				
148.243	V	Stable	48.1	-17.8	30.3	50	19.7	Pass	103	300		
206.767	V	Stable	50.8	-15.7	35.1	50	14.9	Pass	107	316		
206.752	H	Stable	51	-22	29	50	21	Pass	151	282		
328.742	H	Stable	49.3	-16.7	32.6	57	24.4	Pass	106	104		

DATA SHEET		Date	18-Feb-13
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake

## 1. Line conduction



## 2. Radiated emission

